# Power MOSFET

40 V, 70 A, Single N-Channel, DPAK

### Features

- Low R<sub>DS(on)</sub>
- High Current Capability
- Low Gate Charge
- STD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### Applications

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage	e		V <sub>GS</sub>	±20	V
Continuous Drain	Steady		I <sub>D</sub>	70	А
Current – $R_{\theta JC}$	State	$T_{C} = 125^{\circ}C$		40	
Power Dissipation – $R_{\theta JC}$	Steady State	$T_{C} = 25^{\circ}C$	PD	100	W
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	12.2	А
Current – R <sub>0JA</sub> (Note 1)	Sidle	T <sub>A</sub> = 125°C		7.0	
Power Dissipation – R <sub>θJA</sub> (Note 1)	Steady State	$T_A = 25^{\circ}C$	P <sub>D</sub>	3.0	W
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	150	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 175	°C
Source Current (Body Diode) Pulsed			۱ <sub>S</sub>	63.5	А
Single Pulse Drain-to Source Avalanche Energy – (V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, I <sub>PK</sub> = 30 A, L = 1 mH, R <sub>G</sub> = 25 $\Omega$ )			EAS	450	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Мах	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient (Note 1)	$R_{\thetaJA}$	49	

1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



## **ON Semiconductor®**

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX (Note 1)
40 V	8.7 mΩ @ 10 V	70 A





#### MARKING DIAGRAM



\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### ORDERING INFORMATION

Device	Package	Shipping†
NTD5406NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
STD5406NT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
STD5406NT4G-VF01	DPAK (Pb–Free)	2500 / Tape & Reel

+For information on tape and reel specifications,

including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_{D}$ = 250 $\mu A$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				42		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	μΑ
		V <sub>DS</sub> = 40 V	$T_J = 100^{\circ}C$			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_G$	<sub>S</sub> = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.5		3.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I	<sub>D</sub> = 30 A		8.7	10	mΩ
		V <sub>GS</sub> = 5.0 V,	I <sub>D</sub> = 10 A		13.2	17	
Forward Transconductance	9FS	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A			19		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 32 V			1375	2500	pF
Output Capacitance	C <sub>OSS</sub>				370	700	
Reverse Transfer Capacitance	C <sub>RSS</sub>				160	300	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V},$ $I_D = 30 \text{ A}$			45		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.0		
Gate-to-Source Charge	Q <sub>GS</sub>				5.4		
Gate-to-Drain Charge	Q <sub>GD</sub>				20		
SWITCHING CHARACTERISTICS, Vo	<sub>SS</sub> = 10 V (Note	3)					
Turn–On Delay Time	t <sub>d(ON)</sub>				7.2		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 32 \text{ V},$ $I_D = 30 \text{ A}, R_G = 2.5 \Omega$			57		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				30		
Fall Time	t <sub>f</sub>		ľ		67		
SWITCHING CHARACTERISTICS, Vo	s = 5 V (Note 3	)					
Turn–On Delay Time	t <sub>d(ON)</sub>				15		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 5.0 V, V	חם = 20 V,		147		
Turn–Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D} = 30  \rm A,  R_{\rm C}$	<sub>G</sub> = 2.5 Ω		20		
Fall Time	t <sub>f</sub>	<u>1                                    </u>			29		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.82	1.1	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.67		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 V, dI_{SD}/dt = 100 A/\mu s,$ $I_{S} = 10 A$			46		ns
Charge Time	t <sub>a</sub>				24		1
Discharge Time	t <sub>b</sub>				22		1
Reverse Recovery Charge	Q <sub>RR</sub>				65		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. 3. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL PERFORMANCE CURVES**



### **TYPICAL PERFORMANCE CURVES**



Figure 11. Maximum Rated Forward Biased Safe Operating Area

## **TYPICAL PERFORMANCE CURVES**



#### PACKAGE DIMENSIONS

**DPAK (SINGLE GAUGE)** CASE 369C

**ISSUE F** 



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
  - MENSIONS b3, L3 and Z.
- A DIMENSIONS DAILS and Z. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE. DIMENSION D AND E ADD EXTERNMENT
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H. 7 OPTIONAL MOLD FEATURE

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29	9 BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114 REF		2.90	REF	
L2	0.020	BSC	0.51	I BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

 $\left(\frac{mm}{inches}\right)$ 

SCALE 3:1

DRAIN 4.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and ware trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="https://www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typical" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative